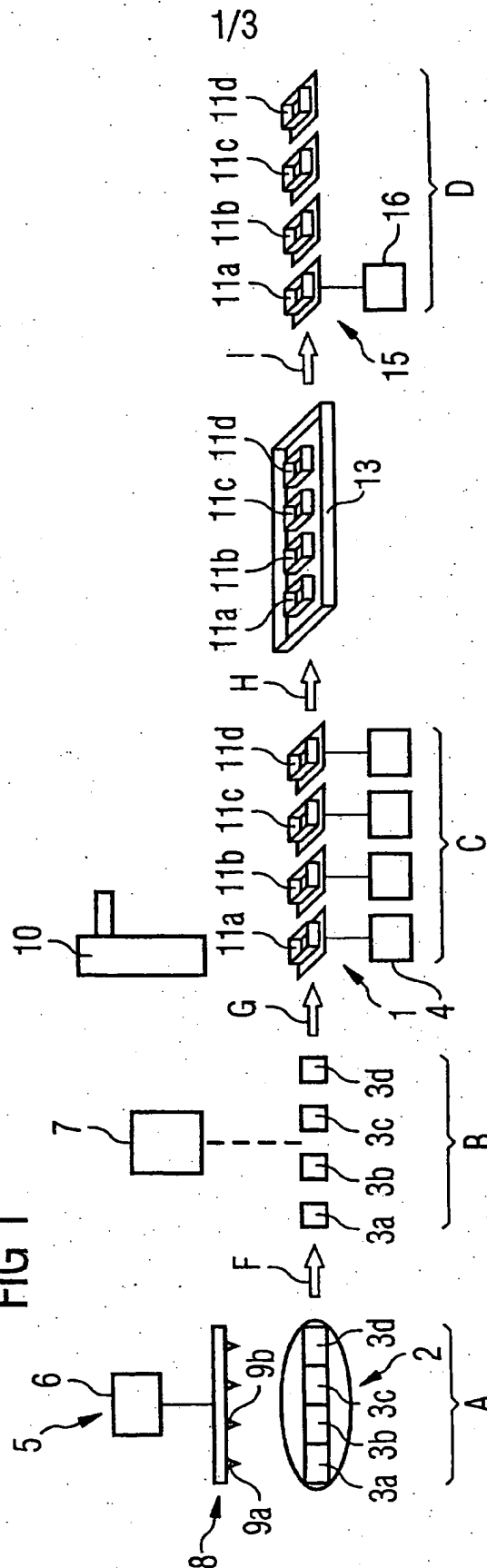
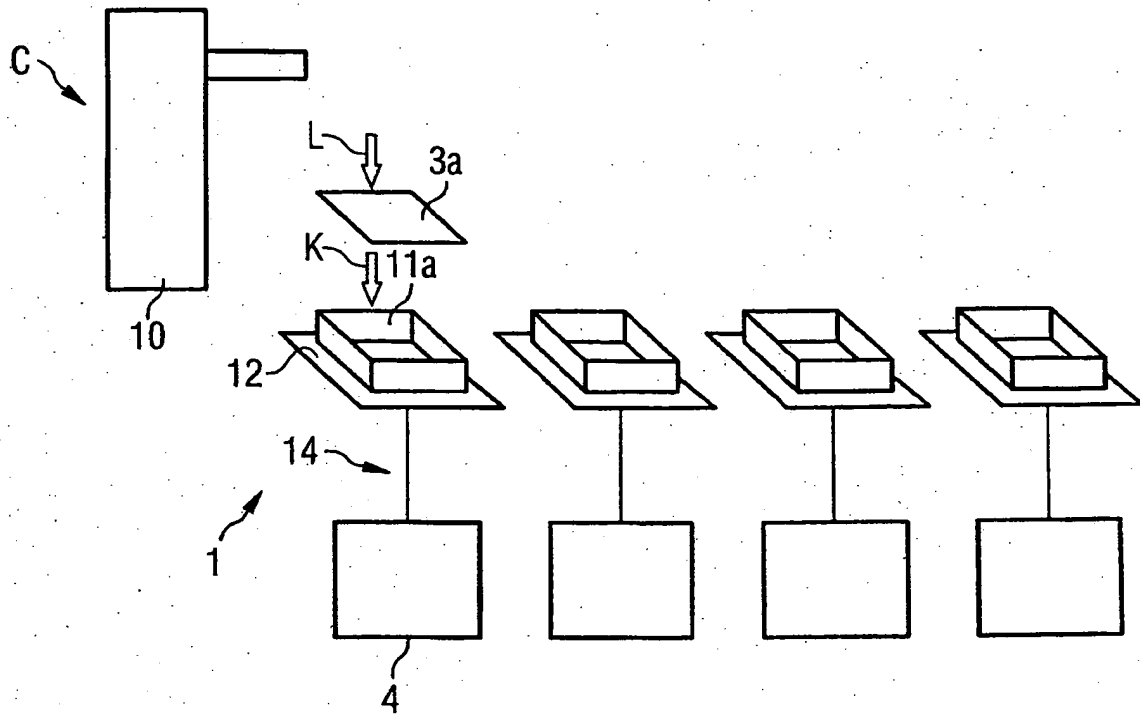


FIG 1



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FIG 2



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Title: TESTING APPARATUS AND METHOD FOR TESTING THE CONTACTING BETWEEN

THE CONTACTING BETWEEN A SEMICONDUCTOR DEVICE AND A CARRIER

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FIG 3

